

## U.S. PATENT APPLICATION

|               |                     |       | GROUP ART UNIT |
|---------------|---------------------|-------|----------------|
| SERIAL NUMBER | FILING DATE         | CLASS | GROUP ART UNIT |
| 07/949,652    | 09/23/92<br>RULE 60 | 435   | 1807           |

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\*\*CONTINUING DATA\*\*\*\*\*\*\*\*\*\*\*

THIS APPLN IS A CON OF VERIFIED

07/551,239 07/11/90 WHICH IS A CIP OF

WHICH IS A CIP OF

07/465,863 01/16/90 ABN 07/405,499 09/11/89 ABN

WHICH IS A CIP OF

07/398,217 08/25/89 ABN

\*\*FOREIGN/PCT APPLICATIONS\*\*\*\*\*\*\* VERIFIED

\*\*\*\* SMALL ENTITY \*\*\*\*

| STATE OR<br>COUNTRY | SHEETS<br>Drawing | TOTAL<br>CLAIMS | INDEPENDENT | FILING FEE<br>RECEIVED | ATTORNEY DOCKET NO. |
|---------------------|-------------------|-----------------|-------------|------------------------|---------------------|
| NZX                 | 0                 | 34              | 12          | \$ 925.00              | M-1647-6C-US        |

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> INTRON SEQUENCE ANALYSIS METHOD FOR DETECTION OF ADJACENT AND REMOTE LOCUS ALLELES AS HAPLOTYPES

This is to certify that annexed hereto is a true copy from the records of the United States Patent and Trademark Office of the application as filed which is identified above.

By authority of the COMMISSIONER OF PATENTS AND TRADEMARKS

Certifying Officer